

Search Notes 	Application/Control No.	Applicant(s)/Patent under Reexamination
	09/911,338	SEIDL ET AL.
	Examiner	Art Unit
	PHUC H. TRAN	2666

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
370	230	8/18/2005	PT
370	368	8/18/2005	PT